

Application/Control No.	Applicant(s)/Patent under Reexamination
10/708,276	LIU ET AL.
Examiner	Art Unit

Esaw T. Abraham

2112

	SEARCHED				
Class	Subclass	Date	Examiner		
714	30, 718, 733, 799	10/17/2007	EA		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR		)
	DATE	EXMR
East Text search	10/17/2007	EA
PALM inventor search	10/17/2007	EΑ
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